

<b>Notice of References Cited</b>	Application/Control No. 10/711,476	Applicant(s)/Patent Under Reexamination TAN ET AL.	
	Examiner Brian J. Livedalen	Art Unit 2878	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,828,543	12-2004	Chen, Wen-Ching	250/208.1
*	B	US-6,518,656	02-2003	Nakayama et al.	257/680
*	C	US-2002/0057468	05-2002	Segawa et al.	358/509
*	D	US-6,395,124	05-2002	Oxman et al.	156/275.5
*	E	US-2003/0214024	11-2003	Ono, Koji	257/686
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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